

<b>Notice of References Cited</b>	Application/Control No. 10/567,211		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner TUNG X. LE		Art Unit 2821	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0012467	01-2005	Nemirow et al.	315/247
*	B	US-2004/0012347	01-2004	Ribarich, Thomas J.	315/291
*	C	US-2003/0107332	06-2003	Newman et al.	315/307
*	D	US-5,872,429	02-1999	Xia et al.	315/194
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.